

EAST Search History

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|--------|---|--|------------------|---------|------------------|
| L5 | 8784 | ((438/197) or (438/299) or (438/585) or (438/587) or (438/588) or (438/592) or (438/652) or (438/653) or (438/654) or (438/656) or (438/657) or (438/680) or (438/684)).CCLS. | US-PGPUB; USPAT | OR | OFF | 2007/06/11 10:47 |
| S1 | 2 | "20050247985" | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2007/01/07 17:53 |
| S3 | 21739 | high adj dielectric adj constant | US-PGPUB; USPAT | OR | ON | 2007/05/08 14:59 |
| S4 | 2218 | gate and (gate near insulat\$3) and (Hfsi Zr) | US-PGPUB; USPAT | OR | ON | 2007/06/02 17:24 |
| S5 | 710 | S3 and S4 | US-PGPUB; USPAT | OR | ON | 2007/05/08 15:07 |
| S6 | 174665 | gate and silicon oxide and depth and distribut\$3 and ((gate near insulat\$3) near (Zr Hf Ta Al Ti Nb Sc Y La Ce Pr Nd Sm Eu Gd Tb Dy Ho Er Tm Yb Lu)) | US-PGPUB; USPAT | OR | ON | 2007/05/08 15:07 |
| S7 | 2075 | S6 and S4 | US-PGPUB; USPAT | OR | ON | 2007/05/08 15:07 |
| S8 | 204 | S5 and @ad<"20020619" | US-PGPUB; USPAT | OR | ON | 2007/05/08 15:08 |
| S13 | 569 | (tan hfo si) adj mosfet | US-PGPUB; USPAT | OR | ON | 2007/06/02 17:38 |
| S14 | 310 | S13 and @ad<"20020627" | US-PGPUB; USPAT | OR | ON | 2007/06/02 17:30 |
| S15 | 0 | (tan hfo) adj mosfet | US-PGPUB; USPAT | OR | ON | 2007/06/02 17:38 |
| S16 | 21 | (tan hfo) near2 mosfet | US-PGPUB; USPAT | OR | ON | 2007/06/02 17:42 |
| S17 | 20 | (hag-ju near cho).in. | US-PGPUB; USPAT | OR | ON | 2007/06/02 17:47 |
| S18 | 14 | ("20020104481" "5316982" "5668021" "5668054" "6153519" "6168991" "6203613" "6204204" "6221712" "6357901" "6492217" "6504214" "6537901" "6607958").PN. | US-PGPUB; USPAT | OR | ON | 2007/06/02 17:54 |
| S19 | 7 | "6380104" | US-PGPUB; USPAT | OR | ON | 2007/06/02 23:10 |
| S20 | 0 | (Tanaka adj nobufumi).in. | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:02 |
| S21 | 0 | (Tanaka near nobufumi).in. | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:02 |

EAST Search History

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|-----|--------|--|---|----|----|------------------|
| S22 | 148 | (nobufumi).in. | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:02 |
| S23 | 637302 | nitrogen | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:03 |
| S24 | 17 | S22 and S23 | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:04 |
| S25 | 0 | (stack\$3 adj gate) with (nitrogen adj concentrat\$3) with (high adj dielectric adj constant) and (gate near insulat\$3) and (silicon adj oxide) | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:06 |
| S26 | 7 | (stack\$3 adj gate) and (nitrogen adj concentrat\$3) and (high adj dielectric adj constant) and (gate near insulat\$3) and (silicon adj oxide) | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:09 |
| S27 | 16 | (stack\$3 adj gate) and (nitrogen adj concentrat\$3) and (high adj dielectric adj constant) | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:09 |
| S28 | 38 | (stack\$3 near gate) and (nitrogen adj concentrat\$3) and (high adj dielectric adj constant) | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:22 |
| S29 | 40 | "5891798" | US-PGPUB; USPAT | OR | ON | 2007/06/02 22:22 |
| S30 | 158 | Dharmarajan.in. | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2007/06/02 22:59 |
| S31 | 6 | "6365467" | US-PGPUB; USPAT | OR | ON | 2007/06/02 23:10 |